



## DOCUMENT CHANGE REQUEST

DCR number	191	Changes required for:	General	Originator:	Patrick HARDY -Chief
Date:	2005/07/15	Date sent:	2005/07/15	Organisation:	CNES
Status:	IMPLEMENTED				

Title: Capacitors Fixed Chips Ceramic Dielectric Type I, based on type 0805

Number: 3009/003 Issue: 2

Other documents affected:

3009/004-2, 3009/005-2, 3009/006-2, 3009/022-2

Page:

Addition of Appendix "B" agreed deviations for AVX (F)

Paragraph:

Addition of Appendix "B" agreed deviations for AVX (F)

Original wording:


Proposed wording:

Items affected : para 4.6.2

Description of deviations : table 3 temperature coefficient measurement may be replaced with data provided by the ceramic material supplier, using AVX document(issue as per PID)1A-220020BCR\*\*AQ - 1A-220022DCR\*\*AQ

Justification:

- . Type I ceramic temperature characteristics depend on the nature of the dielectric and do not evolve in time for a specific batch
- . Impact of processing (essentially firing) is minor and nevertheless controlled with insulation resistance and dissipation factor measurements.
- . This proposal is compliant with the flexibility described in paragraph 9 of ESCC 3009 and with the QSA (i.e., CNES)

Attachments:
N/A
Modifications:
N/A
Approval signature:

Date signed:
2005-07-15